

IPW/CJC
#

PATENT
DOCKET NO.: 29284/548

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventors : Mitsuo TOKUDA, et al.
Serial No. : 09/960,479
Filed : September 24, 2001
Patent No. : **6,781,125 B2** Issued August 24, 2004
For : METHOD AND APPARATUS FOR PROCESSING A
MICRO SAMPLE

Mail Stop **CERTIFICATE OF CORRECTION BRANCH**
COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, Virginia 22313-1450

REQUEST FOR CERTIFICATE OF CORRECTION
PURSUANT TO 37 C.F.R. § § 1.322 & 1.323

SIR:

Applicants hereby request that the enclosed Certificate of Correction be issued for the above Patent under authority of 35 USC § § 254 and 255.

The changes represent correction of obvious typographical errors or are mistakes of minor character by the applicants and the U.S. Patent Office and do not introduce new matter.

Please charge Deposit Account No. 11-0600 in the amount of \$100.00 to cover the fee under 37 CFR § 1.20(a). The Office is hereby authorized to charge any fees or credit any overpayments to Deposit Account No. 11-0600. A duplicate of this sheet is included for this purpose.

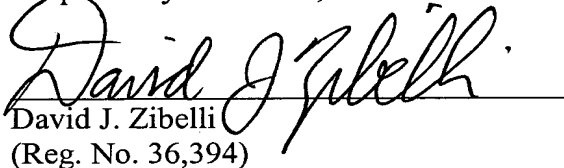
03/30/2005 NNGUYEN1 00000030 110600 6781125
01 FC:1811 100.00 DA

Dated: 3/29/05

KENYON & KENYON
1500 K Street, N.W., Suite 700
Washington, DC 20005

Tel: (202) 220-4200
Fax: (202) 220-4201

Respectfully submitted,


David J. Zibelli
(Reg. No. 36,394)

UNITED STATES PATENT AND TRADEMARK OFFICE

CERTIFICATE OF CORRECTION

PATENT NO. : 6,781,125 B2
DATED : 24 August 2004
INVENTOR(S) : Mitsuo TOKUDA, et al.

Page 1 of 1

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

<u>Column</u>	<u>Line</u>	
	30	Delete the entire line "Feb. 23, 2001 (JP) 2001-049303."
2	11	Change "which falls a technical limit" to --which falls below a technical limit--.
6	34	Change "apples" to --applies--.
23	56-57	Change "miniaturize" to --miniaturized--.
14	16	Change "FIG. 27 is a sectional view when a probe moving mechanism 201 of the present invention is figure, an " to --FIG. 27 is a sectional view of a probe moving mechanism 201 of the present invention. In this figure, an--.
24	16	Delete "is considered to be connected to the circuit in design".
25	10	Change "election beam" to --electron beam--.
25	33	Change "election beam" to --electron beam--.

MAILING ADDRESS OF SENDER:

John C. Altmiller
KENYON & KENYON
1500 K Street, N.W., Suite 700
Washington, DC 20005

Patent No.: 6,512,464 B2